

FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
107391-00000SERIAL NO.
10/673159
Unknown

LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

APPLICANT

Tsuneo OHNO et al.

FILING DATE

September 30, 2003

GROUP

Unknown

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION YES NO PART.		
<i>CMB</i>	AG	JP 2001-133273	May 18, 2001	Japan	21	00		XX	
<i>CMB</i>	AH	JP 2001-165671	June 22, 2001	Japan	21	00		XX	
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	AJ								
	AK								
	AL								

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	AM	
	AN	
	AO	

EXAMINER

Christ M. Behl

DATE CONSIDERED

05-24-2005

*EXAMINER:

Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



PTO/SB/08a (08-03)

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**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**
Form PTO/SB/08a**Complete if Known**

Application Number	10/673,159
Filing Date	September 30, 2003
First Named Inventor	OHNO, et al.
Art Unit	3661
Examiner Name	Unknown
Attorney Docket Number	107391-00000

Sheet 1 of 1

U.S. PATENT DOCUMENTS

Examiner Initials*	Cite No. ¹	Document Number	Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
OMB		US- 6,763,429	B1	7/13/2004	Hiroshi HIRAYAMA	
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Examiner Initials*	Cite No. ¹	Foreign Patent Document	Country Code ³	Number-Kind Code ⁴ (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁵

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